

N-Channel Enhancement Mode MOSFET

1. Product Information

Features

- VD-MOSFET technology
- Improve switching performance

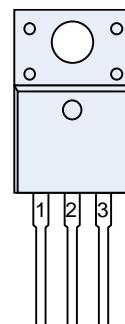
Pin Description

| Pin | Description |
|-----|-------------|
| 1 | Gate(G) |
| 2 | Drain(D) |
| 3 | Source(S) |

Applications

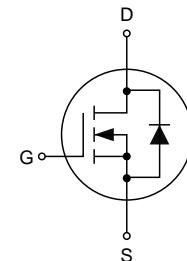
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Simplified Outline



Top View
TO-220F

Symbol



Quick reference

- $V_{DS} = 200 \text{ V}$
- $I_D = 28 \text{ A}$
- $R_{DS(ON)} \leq 100 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$ (Type: 80 mΩ)

Package Marking and Ordering Information

| Product Name | Package | Marking | Reel size | Tape width | Quantity (pcs) |
|--------------|---------|---------------------|-----------|------------|----------------|
| KJ28N20CF | TO-220F | KJ28N20CF XXXXYY | N/A | N/A | 1000 |

2. Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Values | Unit |
|-----------------|--|----------|------|
| V_{DS} | Drain-Source Voltage, $V_{GS}=0\text{V}$ | 200 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| I_D | Continuous Drain Current | 28 | A |
| I_{DM} | Pulsed Drain Current ¹ | 84 | A |
| E_{AS} | Single Pulse Avalanche Energy ² | 340 | mJ |
| P_D | Power Dissipation @ $T_C=25^\circ\text{C}$ | 104 | W |
| T_J, T_{STG} | Operating Junction and Storage Temperature Range | -55~150 | °C |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 62.5 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance Junction to Case | 1.2 | °C/W |

3. Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|----------------------------|---|--|------|------|-----------|------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{\text{GS}}=0 \text{ V}, I_{\text{D}}=250 \mu\text{A}$ | 200 | 220 | - | V |
| I_{GSS} | Gate-body Leakage current | $V_{\text{DS}}=0 \text{ V}, V_{\text{GS}}=\pm 20 \text{ V}$ | - | - | ± 100 | nA |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{\text{DS}}=200 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J=25^\circ\text{C}$ | - | - | 5 | μA |
| | | $V_{\text{DS}}=160 \text{ V}, V_{\text{GS}}=0 \text{ V}, T_J=125^\circ\text{C}$ | - | - | 100 | |
| $V_{\text{GS}(\text{th})}$ | Gate-Threshold Voltage | $V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250 \mu\text{A}$ | 2 | 3 | 4 | V |
| $R_{\text{DS}(\text{on})}$ | Drain-Source on-Resistance ³ | $V_{\text{GS}}=10 \text{ V}, I_{\text{D}}=9 \text{ A}$ | - | 80 | 100 | $\text{m}\Omega$ |
| C_{iss} | Input Capacitance | $V_{\text{GS}}=0 \text{ V}, V_{\text{DS}}=25 \text{ V}, f=1 \text{ MHz}$ | - | 1511 | - | pF |
| C_{oss} | Output Capacitance | | - | 192 | - | |
| C_{rss} | Reverse Transfer Capacitance | | - | 81 | - | |
| Q_g | Total Gate Charge | $V_{\text{DS}}=160 \text{ V}, V_{\text{GS}}=10 \text{ V}, I_{\text{D}}=18 \text{ A}$ | - | 43 | - | nC |
| Q_{gs} | Gate-Source Charge | | - | 6 | - | |
| Q_{gd} | Gate-Drain Charge | | - | 20 | - | |
| $t_{\text{d}(\text{on})}$ | Turn-on Delay Time | $V_{\text{DD}}=100 \text{ V}, R_{\text{G}}=25 \Omega, I_{\text{D}}=18 \text{ A}$ | - | 24 | - | ns |
| t_r | Turn-on Rise Time | | - | 46 | - | |
| $t_{\text{d}(\text{off})}$ | Turn-off Delay Time | | - | 108 | - | |
| t_f | Turn-off Fall Time | | - | 94 | - | |
| I_s | Continuous Source Current | $T_c=25^\circ\text{C}$ | - | - | 28 | A |
| I_{SM} | Pulsed Diode Forward Current | | - | - | 84 | A |
| V_{SD} | Diode Forward Voltage | $T_J=25^\circ\text{C}, I_{\text{SD}}=18 \text{ A}, V_{\text{GS}}=0 \text{ V}$ | - | - | 1.4 | V |
| t_{rr} | Body Diode Reverse Recovery Time | $V_{\text{GS}}=0 \text{ V}, I_s=18 \text{ A}, dI/dt=100 \text{ A}/\mu\text{s}$ | - | 233 | - | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | | - | 1.9 | - | μC |

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2 OZ copper.
2. The EAS data shows Max. rating. $I_{\text{AS}}=20 \text{ A}, V_{\text{DD}}=50 \text{ V}, R_{\text{G}}=25 \Omega$, Starting $T_J=25^\circ\text{C}$.
3. The test condition is Pulse Test: Pulse width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 1\%$.
4. The power dissipation is limited by 150°C junction temperature.
5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

4. Typical Characteristics

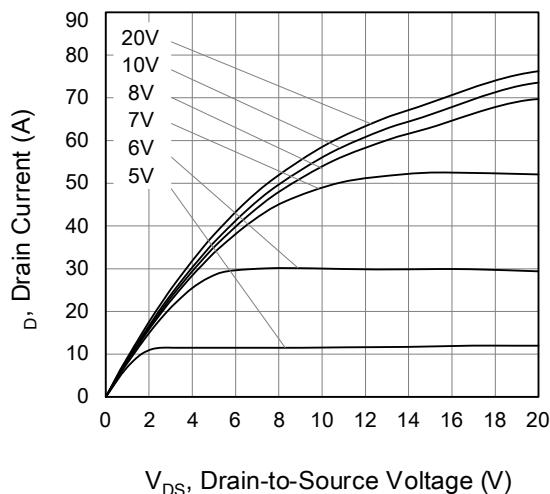


Figure 1: Output Characteristics ($T_J=25^\circ\text{C}$)

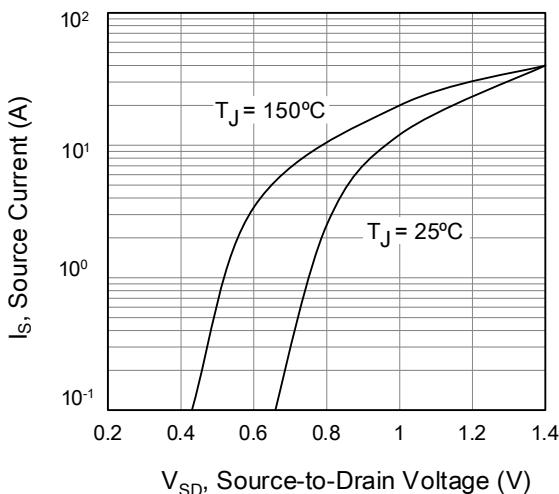


Figure 2: Body Diode Forward Voltage

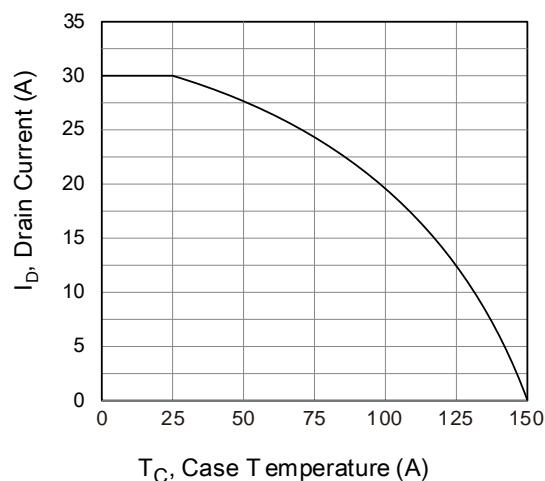


Figure 3: Drain Current vs. Temperature

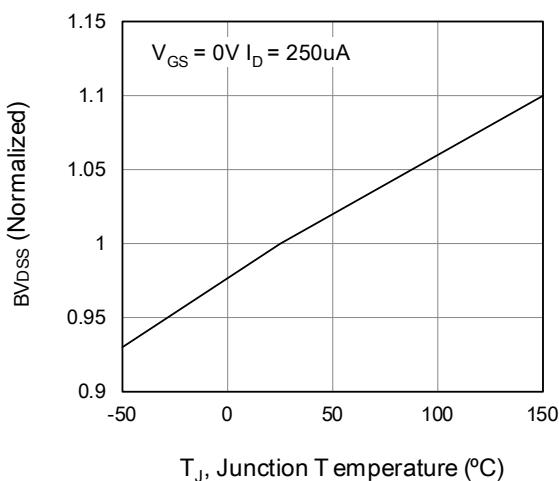


Figure 4: Body Diode Characteristics

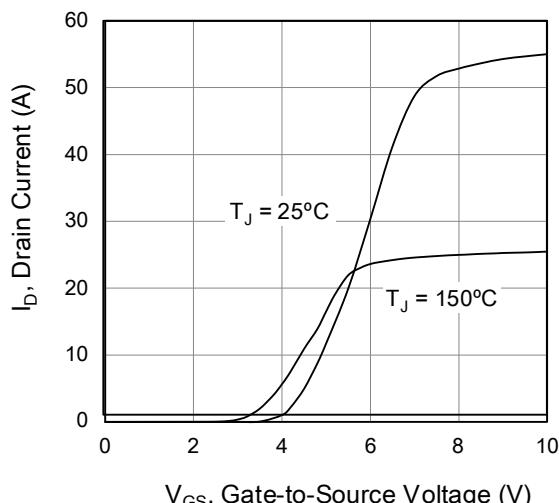


Figure 5: Transfer Characteristics

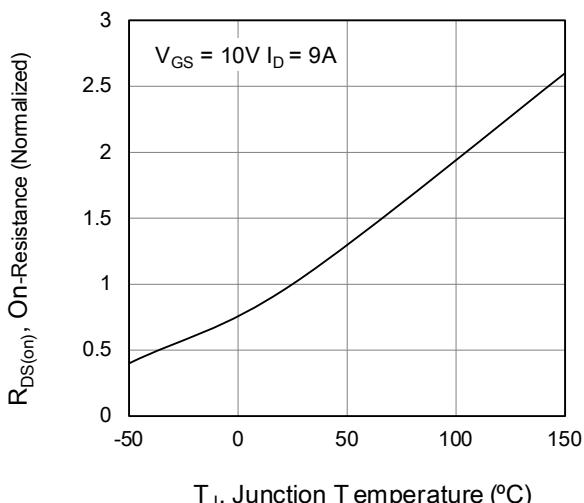


Figure 6: On-resistance vs. Temperature

4. Typical Characteristics (cont.)

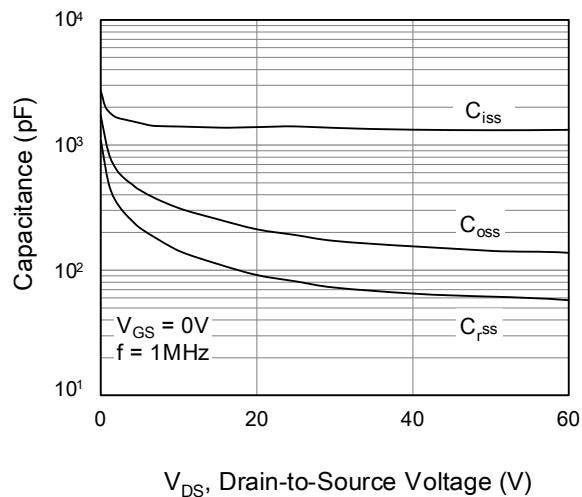


Figure 7: Capacitance

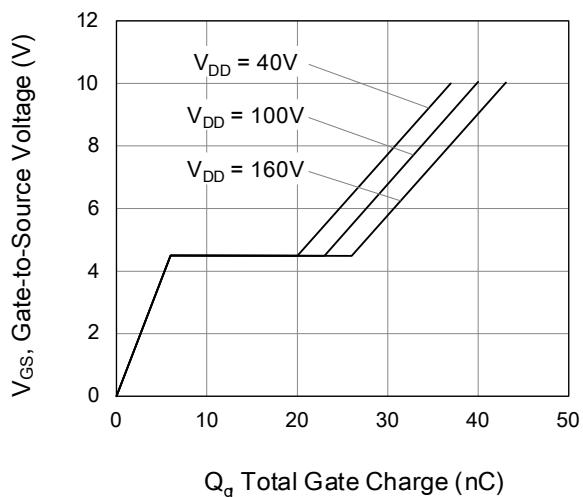


Figure 8: Gate Charge

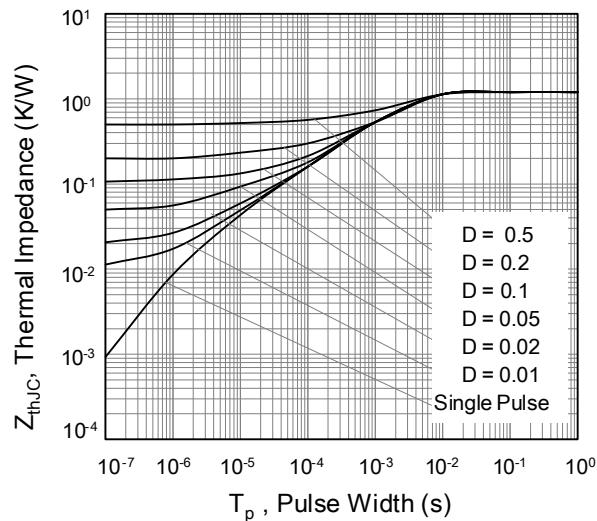
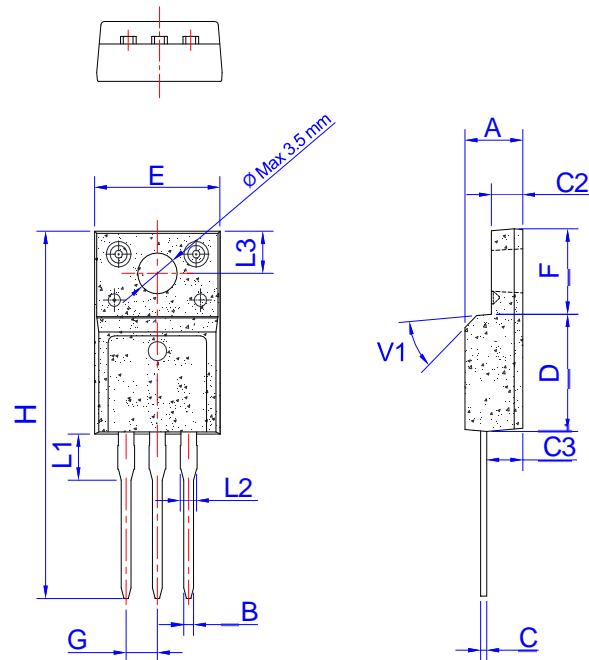


Figure 9: Transient Thermal Impedance

5. Package Mechanical Data

TO-220F Package



| Symbol | Dimensions in Millimeters | | |
|--------|---------------------------|------|------|
| | MIN | NOM | MAX |
| A | 4.50 | | 4.90 |
| B | 0.74 | 0.80 | 0.83 |
| C | 0.47 | | 0.65 |
| C2 | 2.45 | | 2.75 |
| C3 | 2.60 | | 3.00 |
| D | 8.80 | | 9.30 |
| E | 9.80 | | 10.4 |
| F | 6.40 | | 6.80 |
| G | | 2.54 | |
| H | 28.0 | | 29.8 |
| L1 | | 3.63 | |
| L2 | 1.14 | | 1.70 |
| L3 | | 3.30 | |
| V1 | | 45° | |